

Transport Properties of Quantum Interference Devices the Role of the Andreev Bound States

Attia A. Awad Alla, A.M. Hegazy Adel H. Phillips**
and Raafat K. Wassef****

**Faculty of Science, Cairo University, Beni-Suef Branch, Egypt.*

***Faculty of Engineering, Ain-Shams University, Abassia, Cairo, Egypt.*

****Faculty of Science, Cairo University, Giza, Egypt.*

Quantum transport characteristic of a mesoscopic systems under the effect of Coulomb blocked and magnetic field are studied. This system is modeled as two semiconductor quantum dots which are coupled to a superconducting lead via quantum point contacts. The Josephson current density has been obtained in terms of the Andreev reflection amplitude. This Andreev reflection amplitude was deduced by solving the Bogoliubov – de Gennes (BdG) equation, describing the electron transport through the present studied junction. Numerical calculation of the obtained current density has been performed. The dependence of the current density on phase angle ϕ shows a periodic variation. While the oscillation features of the current density with the magnetic field are predicted to be due to quantum interference of electron waves. So such junction can be operated as a quantum interference tuner which may be valuable for nanotechnology.

Introduction:

In recent years, the ballistic transport phenomena in mesoscopic systems have received a great deal of attention. With device dimensions smaller than the electron phase coherence length as well as the elastic mean free path, the scattering and propagation of electrons are described by phase – coherent wave function.

The electronic stub tuner, a quantum interference device, has been studied by many authors (1-9). A conductance oscillations were observed. The results were explained as the quantum interference of electronic waves propagating along the wire and the stub.

In the present paper, a model was proposed as two semiconductor quantum dots coupled to a superconducting lead via quantum point contacts. The quantum transport characteristics of this model are studied under the effect of coulomb blockade and a magnetic field. The present device has not been studied previously.

Theoretical Treatment and the Model

In this model we shall study the transport properties of a quantum interface device, i.e. the electronic stub tuner under the effect of the magnetic field, B . This model is schematically represented in Fig. (1) as the S-Sm-S-Sm-S (S-superconductor, Sm-semiconductor). The dc Josephson current is calculated by solving the Bogoliubov-de Gennes equation (BdG) [10].

$$\begin{pmatrix} H & \Delta \\ \Delta^* & -H \end{pmatrix} \Psi(x) = E \Psi(x) \quad (1)$$

The pair potential Δ in this case is given by

$$\Delta(x) = \begin{cases} \Delta_0 \exp(i\phi) & , x < 0 \\ 0 & , 0 < x < L \\ \Delta_0 \exp(i\phi) & , L < x < 2L \\ 0 & , 2L < x < 3L \\ \Delta_0 \exp(i\phi) & , x > 3L \end{cases} \quad (2)$$

where Δ_0 is the energy gap of the superconductor, ϕ is the phase difference of the Cooper pair and L is the distance between the two successive superconducting reservoir's. The Hamiltonian, H for this model is expressed as

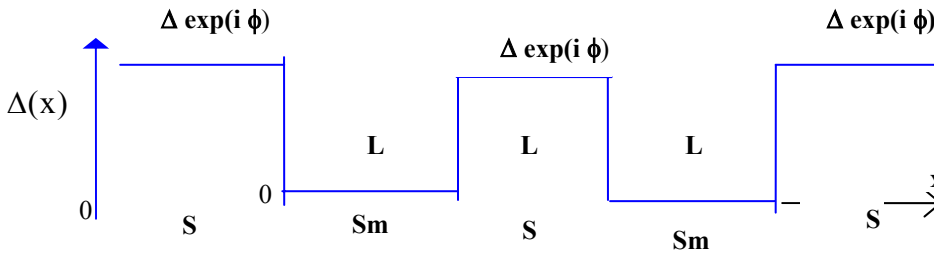


Fig.(1) Schematic representation of a S-Sm-S-Sm-S junction with step wise pair potential.

$$H = -\frac{\hbar^2}{2m} \frac{d^2}{dx^2} - \frac{j^2 \pi^2}{b^2} + V_0 - E_F + \frac{U_C N^2}{2} + e\eta V_g N + S + \frac{\hbar e B}{2m} \quad (3)$$

In Eq.(3), b , is the width of the semiconductor stub.

There are two kinds of bound states, according to the processes that set up the bound states. The first, called the p-process [11], is constructed from eigenstates having superscript (+), which is associated with right going electronlike quasiparticles in the semiconductor regions. The second called n-process, is constructed from eigenstates having superscript (-) and is associated with right-going holelike quasiparticles in the semiconductor regions. Now, accordingly, the p-process eigenfunction is given by[12]

$$\Psi(x) = \begin{cases} (a\Psi_{S,h}^+ / (|u_0|^2 + |v_0|^2)^{0.5}) & , \text{ region(I)} \\ C_1 \Psi_{S,m,e}^+ + D_1 \Psi_{S,m,h}^+ & , \text{ region(II)} \\ (c\Psi_{S,e}^+ + d\Psi_{S,h}^+) / (|u_0|^2 + |v_0|^2)^{0.5} & , \text{ region(III)} \\ C_2 \Psi_{S,m,e}^+ + D_2 \Psi_{S,m,h}^+ & , \text{ region(IV)} \\ (b\Psi_{S,e}^+) / (|u_0|^2 + |v_0|^2)^{0.5} & , \text{ region(V)} \end{cases} \quad (4)$$

The subscript e (h) indicates the electronlike (holelike)quasiparticle. u_0 and v_0 in Eq.(4) is given by Eq

$$u_o = \sqrt{\frac{1}{2} \left(1 + \frac{(E^2 - \Delta_o^2)^{1/2}}{E} \right)} \quad , \quad v_o = \sqrt{\frac{1}{2} \left(1 - \frac{(E^2 - \Delta_o^2)^{1/2}}{E} \right)} \quad (5)$$

The n-process eigenfunction can be obtained from Eq.(4) by changing the superscript (+) to (-) and the subscript (e,h) to (h,e). In Eq.(4) normalized eigenfunctions in the semiconductor regions are expressed as

$$\Psi_{Sm,e}^{\pm}(x) = \begin{pmatrix} 1 \\ 0 \end{pmatrix} \exp(\pm i k_e \tilde{x}) \quad (6a)$$

$$\Psi_{Sm,h}^{\pm}(x) = \begin{pmatrix} 0 \\ 1 \end{pmatrix} \exp(\pm i k_h \tilde{x}) \quad (6b)$$

Where the parameter $\tilde{k}_{e,h}$ is given by

$$\tilde{k}_{e,h} = \left(\frac{2m}{\hbar^2} \right)^{0.5} \left[U_{\pm} + \sigma^{e,h} E - \left(\frac{j\pi}{b} \right)^2 \right]^{0.5} \quad (7)$$

Where $\sigma^e = 1$ for electronlike quasiparticle, $\sigma^h = -1$ for holelike quasiparticle.

and the normalized eigenfunctions in the superconductor regions are given by

$$\Psi_{s,e}^{\pm} = \begin{pmatrix} u_o \exp(i\varphi) \\ v_o \end{pmatrix} \exp(\pm i k_e x) \quad (8a)$$

$$\Psi_{s,h}^{\pm} = \begin{pmatrix} v_o \exp(i\varphi) \\ u_o \end{pmatrix} \exp(\pm i k_h x) \quad (8b)$$

where $k_{e,h}$ is given by

$$k_{e,h} = \left(\frac{2m}{\hbar^2} \right)^{0.5} \left[U_{\pm} + \sigma^{e,h} (E^2 - \Delta_o^2)^{0.5} - \left(\frac{j\pi}{b} \right)^2 \right]^{0.5} \quad (9)$$

in which

$$U_{\pm} = \frac{U_C N^2}{2} + e\eta V_g N + S + \frac{\hbar e B}{2m} + V_0 \pm E_F \quad (10)$$

The current density, \mathbf{J} , due to the Andreev levels can be calculated by using the following Eq.[13]

$$J = \left(\frac{e\hbar}{m}\right) \sum_{\alpha=\pm 1} \alpha_{k_{e,h}^{\pm}} [\tanh(E/2k_B T)]^2 \left(\frac{e^2}{\Delta_0 L}\right)^{0.25} \{f_{FD}(U-V_0) - f_{FD}(U)\} \left[\frac{\Gamma_p \Gamma_n}{\Gamma_p + \Gamma_n}\right] \quad (11)$$

where $\Gamma_{p/n} = |a(E_{\alpha}, \alpha\varphi)|^2$ is the Andreev scattering probability, and $\alpha = +1$ (-1) refers to the p-process and (n-process), and f_{FD} is the Fermi-Dirac distribution function.

The Andreev scattering probability for both, p-process and n-process are obtained after matching the eigenfunctions (Eq.(6a,b , 8a,b) at all S-Sm interfaces, we get

$$\Gamma_p = |a(E_+, +\varphi)|^2 \quad (12)$$

$$= \left(\frac{mV_0}{\hbar^2 k_e}\right) \left(\frac{(u_0^2 + v_0^2)^{0.5}}{u_0 v_0 (\tilde{k}_h - \tilde{k}_e)}\right)^2 (u_0^2 + v_0^2 - 2u_0 v_0 \cos\varphi)$$

$$\Gamma_n = |a(E_-, -\varphi)|^2 \quad (13)$$

$$= \left(\frac{mV_0}{\hbar^2 k_h}\right) \left(\frac{(u_0^2 + v_0^2)^{0.5}}{u_0 v_0 (\tilde{k}_e - \tilde{k}_h)}\right)^2 (u_0^2 + v_0^2 - 2u_0 v_0 \cos\varphi)$$

Substituting Eq. (12,13) in Eq.(11)

$$J = \left(\frac{e\hbar}{m}\right) \sum_j \left(\frac{mV_0}{2\hbar^2}\right) \left[\tanh\left(\frac{E}{2k_B T}\right)\right]^2 \left[\frac{1}{(k_e - k_h)}\right]^2 \left\{1 - \left[1 - \frac{(E^2 - \Delta_0^2)^{0.5}}{E^2}\right] \cos(\varphi)\right\} \left\{4 \left[1 - \frac{(E^2 - \Delta_0^2)^{0.5}}{E^2}\right]^{-1}\right\} \left[\frac{e^2}{\Delta_0 L}\right]^{0.25} \{f_{FD}(U-V_0) - f_{FD}(U)\} \quad (14)$$

The Josephson current density, J, equation (14) depends on the following parameters:

- 1- the phase difference ϕ of the Cooper pair,
- 2- the width of the semiconductor quantum dot, b ,
- 3- the distance, L , between the two superconducting reservoirs,
- 4- the gate voltage, V_g ,
- 5- the energy gap of the superconductor, Δ_0 ,
- 6- the magnetic field, B ,
- 7- the Schottky barrier height, S ,
- 8- the Coulomb energy, U_C , for the number of the electrons ($N+1$) and N in the quantum dot,

These above mentioned parameters can be varied and controlled in order to fabricate the desired junction for optimum utility in microelectronics technology.

Numerical Calculation and Results:

In order to show the reliability of the present theoretical treatment for the present model of superconductor-semiconductor junction, we have performed a numerical calculation. The electron transport through the junction is treated as a stochastic process, so that the tunneled electron energy as a random number. Also, the Schottky barrier height, S , is determined by using the Monte-Carlo simulation technique and its value was found to be ~ 0.47 eV for the case Nb-GaAs Nb-GaAs based heterostructure interface. This value of, S was found in agreement with those found experimentally [14] and by us [15-18]. Also, the number of electrons in the quantum dot is computed by using the Monte-Carlo simulation technique.

1. The variation of the current density, J , with temperature (Fig.2) shows that the decreases of the current as the temperature increases. This result show a qualitative agreement with those published in the literature [19-21]
2. Fig.s (3) show the variation of the current density, J , with, L , for different values of, ϕ , T , B . Also Fig.s (4) show the variation of, J , with, b , under different values of ϕ , T , B . It may be noted that the current density, J , becomes approximately constant where, L , attains a value ~ 80 nm. This value was found to be equal to Fermi wavelength λ_F , for mesoscopic system [22]. But for the case of, b , the current density, J , becomes constant when, b , attains a value ~ 10 nm. This value does not change as the temperature varies. However, the value of, J , does not change when the values of ϕ , and B , vary.

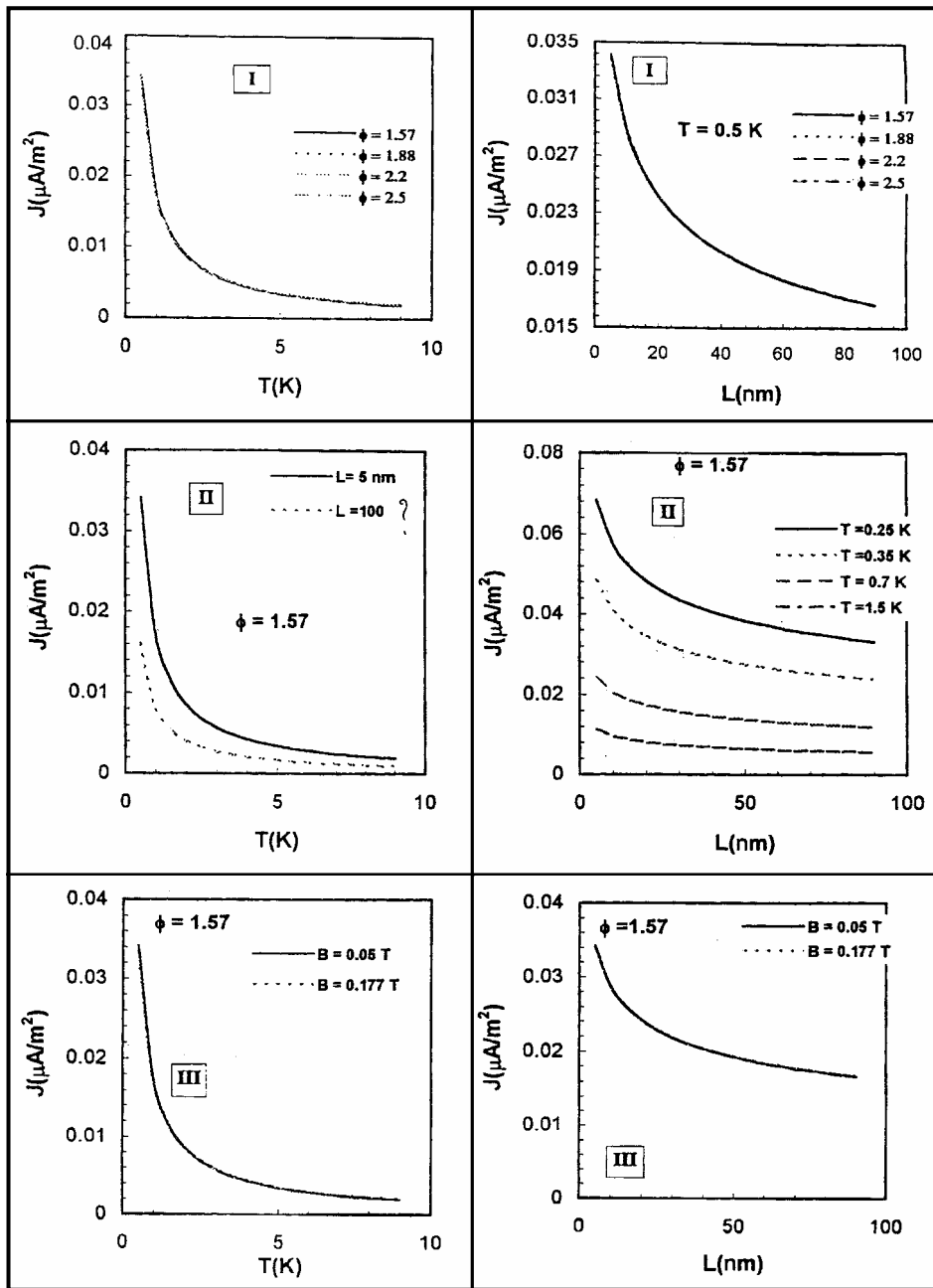


Fig.(2) The current density as a function of temperature relation for different Values of ϕ (I),L(II), and B(III).

Fig.(3) The current density as a function of length of the semiconductor quantum dot relation for different values of ϕ (I), T(II),and B(III).

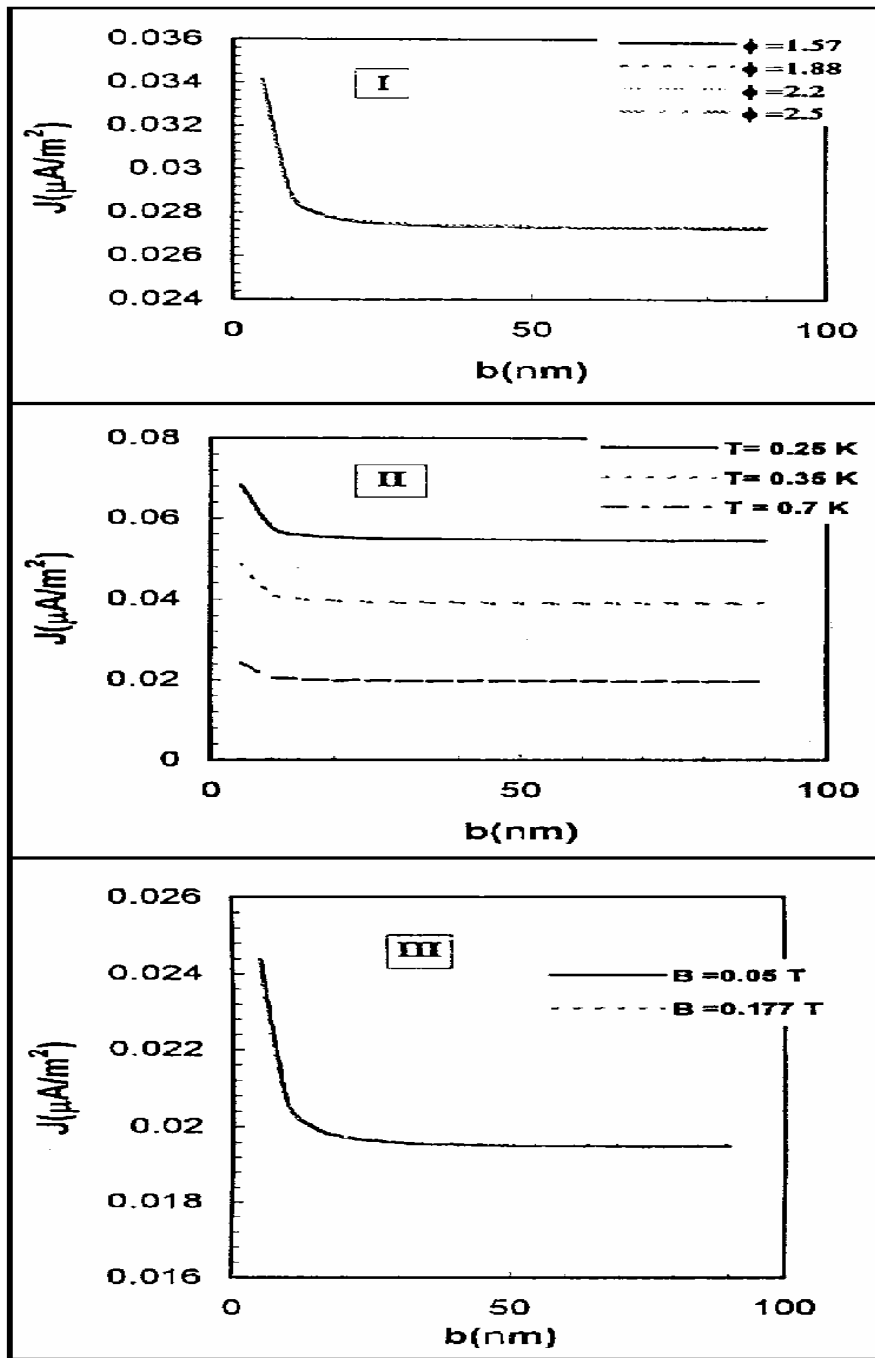


Fig.(4) The current density as a function of the width of the semiconductor quantum dot relation for different values of ϕ (I), T (II), and B (III).

3. A periodic variation of, J , with ϕ is shown in Fig.(5). This result was observed by another authors [13,23] previously which shows the coherent property of the system and it is in a clean limit.
4. The variation of the current density, J , with the magnetic field, B , (Fig.6) show a resonance behavior at the same values of the magnetic field, B . The oscillatory behavior was observed previously [9,24] and this is due to quantum interference of electron under the effect of the magnetic field B .

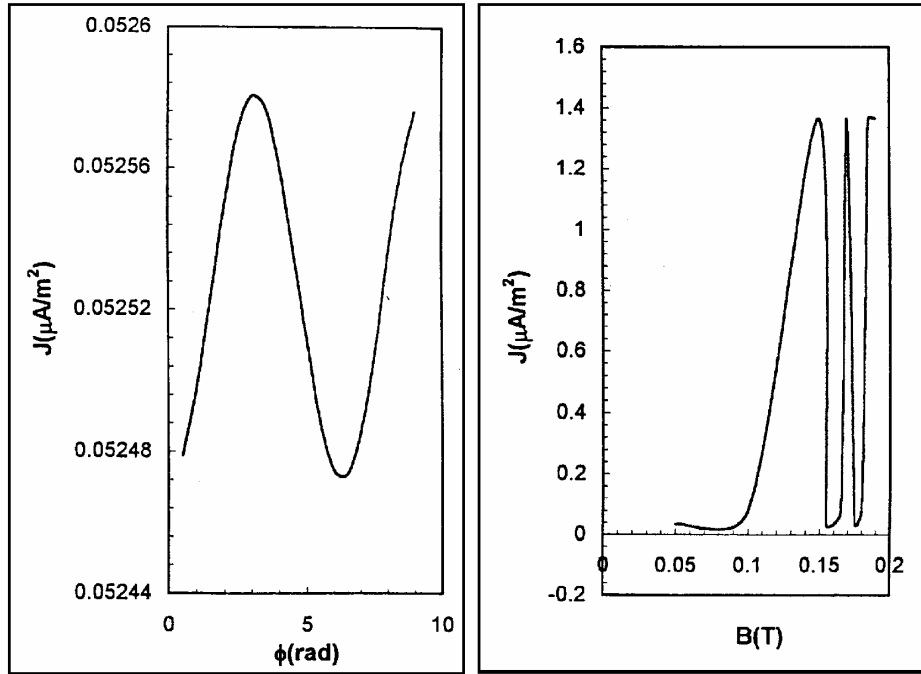


Fig.(5) The variation of the current density with phase angle.

Fig.(6) The variation of current density as a function of magnetic field.

Conclusion:

In this paper we derived a Josephson current density for the proposed device in terms of the Andreev reflection amplitude. The oscillatory behavior of the current density with the magnetic field is explained as the quantum interference of electron waves. We can conclude that such mesoscopic structures used as quantum devices, are predicted to be operational at very high frequencies.

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